

Docket No.: W&B-INF-1947

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : ANDREAS FELBER ET AL.
Filed : CONCURRENTLY HEREWITH
Title : TEST STRUCTURE FOR DETERMINING A SHORT CIRCUIT
BETWEEN TRENCH CAPACITORS IN A MEMORY CELL
ARRAY

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

In accordance with 37 C.F.R. 1.98 copies of the following patents and/or publications are submitted herewith:

U.S. Patent Application Publication No. 2002/0063272 A1 (Miyajima), dated May 30, 2002.

Respectfully submitted,


For Applicants

LAURENCE A. GREENBERG
REG. NO. 29,308

Date: September 30, 2003

Lerner and Greenberg, P.A.
Post Office Box 2480
Hollywood, FL 33022-2480
Tel: (954) 925-1100
Fax: (954) 925-1101

/nt/kf

FORM PTO-1449 (SUBSTITUTE) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT BY APPLICANT (37 CFR 1.98(b))				Attorney Docket No.: W&B-INF-1947 Appl. No.: Applicant: ANDREAS FELBER ET AL. Filing Date: September 30, 2003 Group Art Unit:			
EXAMINER INITIALS		PATENT NO.	DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE
	A	2002/0063272 A1	5/30/02	Miyajima			
	B						
	C						
	D						
	E						
	F						
	G						
	H						
	I						
FOREIGN PATENT DOCUMENT							
		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB CLASS	TRANSL. YES NO
	J						
	K						
	L						
	M						
	N						
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)							
EXAMINER				DATE CONSIDERED			